MOSFET – Power, Single,

P-Channel

-40 V, 13.8 mΩ, -49 A

NVTFS014P04M8L

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS014P04M8L Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR–Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltag	V_{DSS}	-40	V		
Gate-to-Source Voltage	Э		V_{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	-49	Α
Current R _{θJC} (Notes 1, 2, 4)	Steady	T _C = 100°C		-35	
Power Dissipation	State	T _C = 25°C	P _D	61	W
R _{θJC} (Notes 1, 2)		T _C = 100°C		30	
Continuous Drain		T _A = 25°C	I _D	-11.3	Α
Current R _{θJA} (Notes 1, 3, 4)	Steady State	T _A = 100°C		-8	
Power Dissipation		T _A = 25°C	P_{D}	3.2	W
R _{0JA} (Notes 1, 3)		T _A = 100°C		1.6	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	224	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body D	I _S	-50	Α		
Single Pulse Drain-to-S Energy (I _{L(pk)} = -6.1 A)	E _{AS}	143	mJ		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain) (Notes 1, 2, 4)	$R_{ heta JC}$	2.5	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

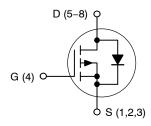


ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
-40 V	13.8 m Ω @ –10 V	-49 A	
	18.7 mΩ @ -4.5 V	-49 A	

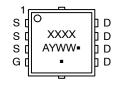
P-Channel MOSFET



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WDFN8 (μ8FL) CASE 511AB

MARKING DIAGRAM



XXXX = Specific Device Code A = Assembly Location

Y = Year
WW = Work Week
Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

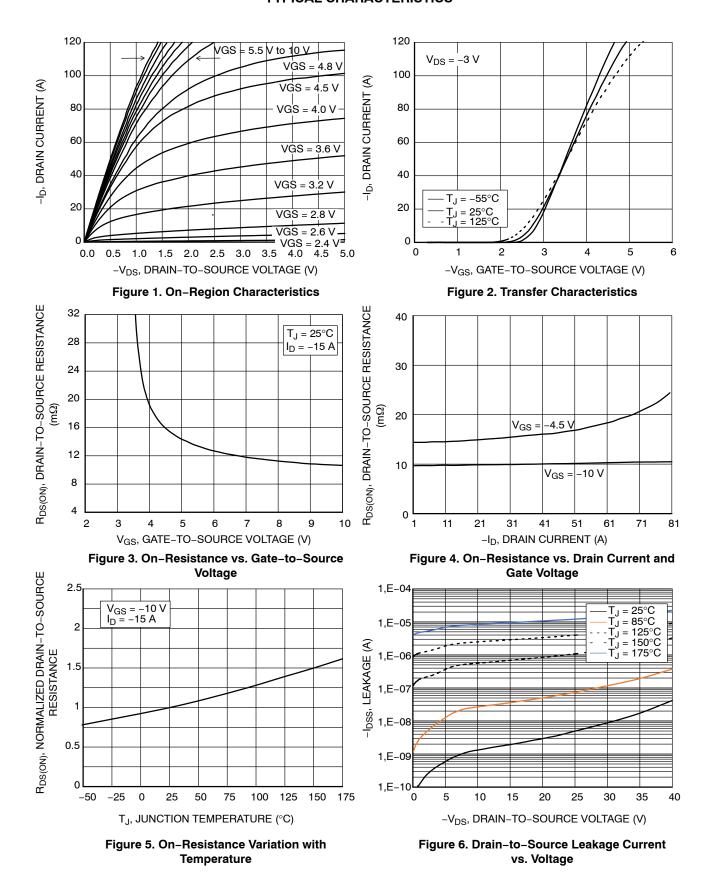
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				21		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V.	T _J = 25°C			-1.0	μΑ
		$V_{GS} = 0 V$, $V_{DS} = -40 V$	T _J = 125°C			-1000	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)					•		•
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	420 μA	-1.0		-2.4	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.1		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -10 V, I _[_O = -15 A		10	13.8	mΩ
	-	$V_{GS} = -4.5 \text{ V, } I_{E}$	₀ = -7.5 A		14.6	18.7	1
Forward Transconductance	9 _{FS}	$V_{DS} = -1.5 \text{ V}, \text{ I}_{I}$	_O = -15 A		42		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = -20 V			1734		pF
Output Capacitance	C _{oss}				682		1
Reverse Transfer Capacitance	C _{rss}	- 503			32		1
Total Gate Charge	Q _{G(TOT)}	V _{DS} = -20 V,	$V_{GS} = -4.5V$		12.5		nC
		$I_{\rm D} = -20 {\rm A}$	V _{GS} = -10V		26.5		1
Threshold Gate Charge	Q _{G(TH)}	l .			2.6		nC
Gate-to-Source Charge	Q_GS	V _{GS} = -10 V, V _D	_{IS} = -20 V,		5.6		1
Gate-to-Drain Charge	Q_GD	$V_{GS} = -10 \text{ V}, V_{DS} = -20 \text{ V},$ $I_{D} = -30 \text{ A}$			3.8		1
Plateau Voltage	V_{GP}				3.2		V
SWITCHING CHARACTERISTICS, VG	is = -4.5 V (Note	e 6)					•
Turn-On Delay Time	t _{d(on)}				11.5		ns
Rise Time	t _r	$V_{GS} = -4.5 \text{ V}, V_{D}$	ıs = −20 V,		97.4		1
Turn-Off Delay Time	t _{d(off)}	V_{GS} = -4.5 V, V_{DS} = -20 V, I_D = -30 A, R_G = 2.5 Ω			44.5		1
Fall Time	t _f			38.2		1	
DRAIN-SOURCE DIODE CHARACTEI	RISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		-0.86	-1.25	V
		$I_{S} = -15 \text{A}$	T _J = 125°C		-0.74		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $I_{S} = -10 \text{ A}$			34.9		ns
Charge Time	t _a				15.8		1
Discharge Time	t _b				19.1		1
Reverse Recovery Charge	Q _{RR}				16.3	52	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS (continued)

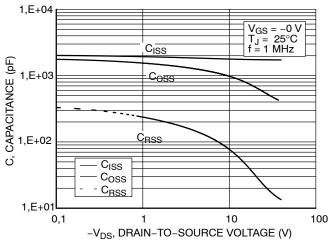
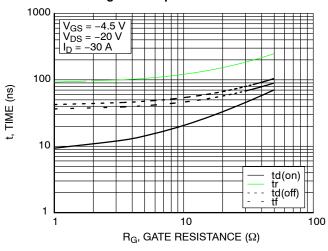


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge



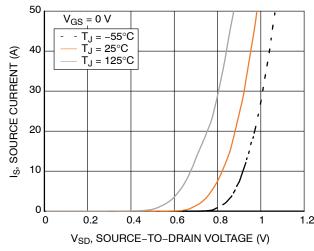
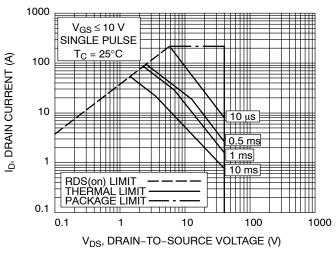


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



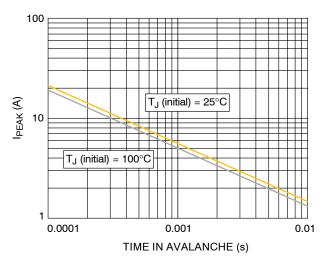


Figure 11. Maximum Rated Forward Biased Dafe operating Area

Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS (continued)

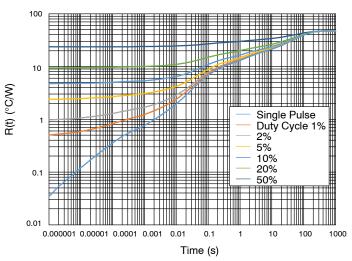


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS014P04M8LTAG	014M	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFWS014P04M8LTAG	014W	WDFN8 (Pb-Free, Wettable Flank)	1500 / Tape & Reel

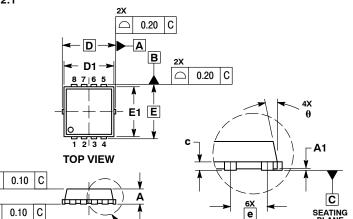
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

DETAIL A

DATE 23 APR 2012

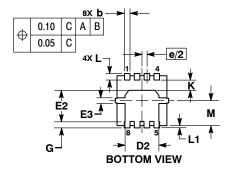


DETAIL A

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC			0.130 BSC		
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E	3.30 BSC			0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC			0.026 BSC		
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	



GENERIC MARKING DIAGRAM*

SIDE VIEW

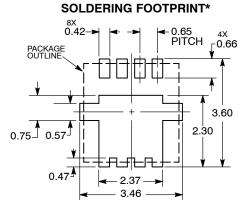


XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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